Search Notes



Application/Control No.	Applicant(s)/Patent under
	Reexamination

10/516,766 PASTAN ET AL.

Examiner Art Unit

David J. Blanchard 1643

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	os:1, 13, 14, 40 and 41	7/15/2008	DB		

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
STIC search SEQ ID Nos:1, 13, 14, 28, 29, 40 and 41 (results in SCORE)	7/15/2008	DB			
Inventor search in PALM	7/14/2008	DB			